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With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

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Power MOSFET

40 V, 14.5 m Ω , 29 A, Dual N-Channel

Features

- Small Footprint (5 x 6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVMFD5C478NLWF Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltag	V_{DSS}	40	V		
Gate-to-Source Voltage	Э		V _{GS}	±20	V
Continuous Drain		T _C = 25°C	I _D	29	Α
Current R _{θJC} (Notes 1, 2, 3, 4)	Steady	T _C = 100°C		20.6	
Power Dissipation	State	T _C = 25°C	P_{D}	23	W
R _{θJC} (Notes 1, 2, 3)		T _C = 100°C		12	
Continuous Drain		T _A = 25°C	I _D	10.5	Α
Current R _{θJA} (Notes 1 & 3, 4)	Steady	T _A = 100°C		7.5	
Power Dissipation	State	T _A = 25°C	P_{D}	3.1	W
R _{θJA} (Notes 1, 3)		T _A = 100°C		1.5	
Pulsed Drain Current	$T_A = 25^\circ$	$T_A = 25^{\circ}C, t_p = 10 \mu s$		98	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to +175	°C
Source Current (Body Diode)			I _S	19	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 1.4 A)			E _{AS}	48	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 3)	$R_{ heta JC}$	6.4	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	48.8	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi (Ψ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.
- Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 4. Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

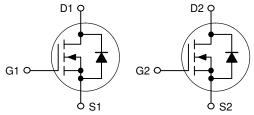


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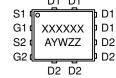
V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
40 V	14.5 mΩ @ 10 V	29 A
40 V	25 mΩ @ 4.5 V	237

Dual-Channel



DFN8, 5x6 (S08FL) CASE 506BT

MARKING AND PIN CONNECTION DIAGRAM D1 D1



XXXXXX = 5C478L (NVMFD5C478NL) or 478LWF (NVMFD5C478NLWF)

A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability
■ Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 5 of this data sheet.

$\textbf{ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•	•			•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D$	= 250 μΑ	40			٧
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			10	μΑ
		$V_{DS} = 40 \text{ V}$	T _J = 125°C			250	1
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{C}$	_{SS} = 20 V			100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{E}$) = 20 μΑ	1.2		2.2	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I	_D = 7.5 A		12.1	14.5	mΩ
		V _{GS} = 4.5 V,	_D = 7.5 A		20	25	1
Forward Transconductance	9FS	V _{DS} = 15 V, I	_D = 15 A		25		S
CHARGES AND CAPACITANCES		_			•	•	
Input Capacitance	C _{iss}				420		pF
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V, f} = V_{DS} = 2$	1.0 MHz, 5 V		185		1
Reverse Transfer Capacitance	C _{rss}	v _{DS} = 25 v			9		1
Total Gate Charge	$Q_{G(TOT)}$				8.1		nC
Threshold Gate Charge	Q _{G(TH)}	1.,			1.0		nC
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 10 \text{ V}, V_{DS} = 32 \text{ V}, I_{D} = 7.5 \text{ A}$			1.7		1
Gate-to-Drain Charge	Q_GD				1.2		1
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 4.5 V, V_{DS} =	32 V, I _D = 7.5 A		3.9		nC
SWITCHING CHARACTERISTICS (No	ote 6)	_			•	•	
Turn-On Delay Time	t _{d(on)}				6		ns
Rise Time	t _r	V _{GS} = 10 V. V _I	ns = 32 V.		14		1
Turn-Off Delay Time	t _{d(off)}	$V_{GS} = 10 \text{ V, } V_{I}$ $I_{D} = 7.5 \text{ A, F}$	$G = 1 \Omega$		18		1
Fall Time	t _f				3.5		1
DRAIN-SOURCE DIODE CHARACTEI	RISTICS				•	•	
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 V$	$T_J = 25^{\circ}C$		0.84	1.2	V
		$I_{S} = 7.5 \text{ A}$	T _J = 125°C		0.72		1
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_S/dt = 100 \text{ A/}\mu\text{s,}$ $I_S = 7.5 \text{ A}$			17		ns
Charge Time	t _a				7.0		1
Discharge Time	t _b				10		1
Reverse Recovery Charge	Q _{RR}				6		nC

^{5.} Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

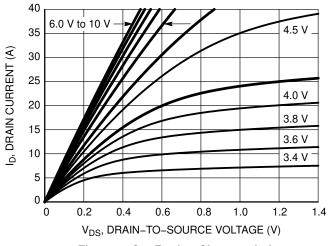


Figure 1. On-Region Characteristics

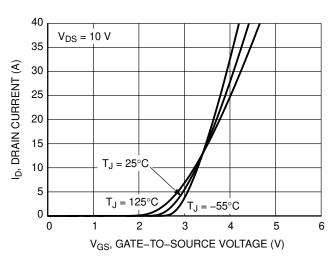


Figure 2. Transfer Characteristics

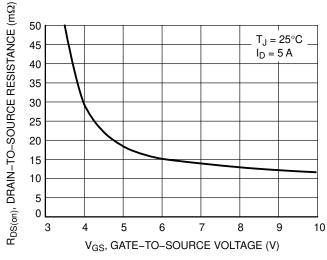


Figure 3. On-Resistance vs. Gate-to-Source Voltage

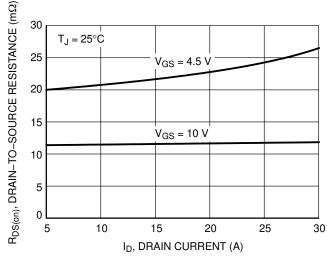


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

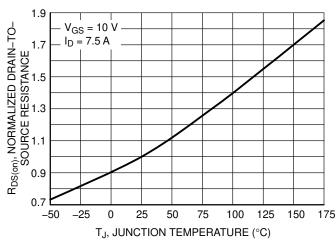


Figure 5. On–Resistance Variation with Temperature

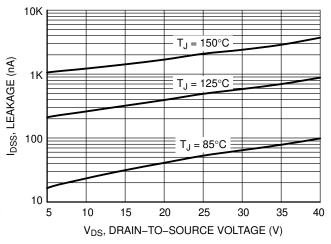


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

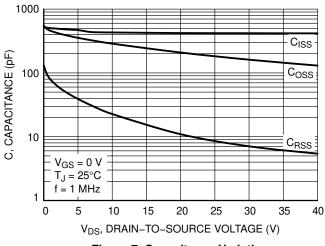


Figure 7. Capacitance Variation

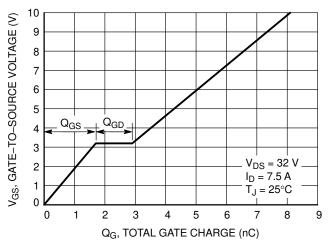
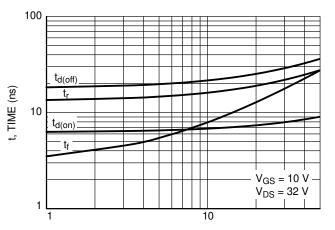


Figure 8. Gate-to-Source Voltage vs. Total Charge



 R_G , GATE RESISTANCE (Ω)

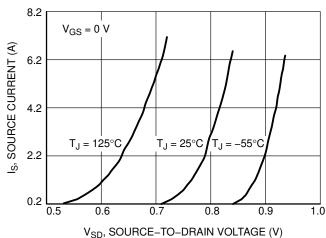


Figure 10. Diode Forward Voltage vs. Current



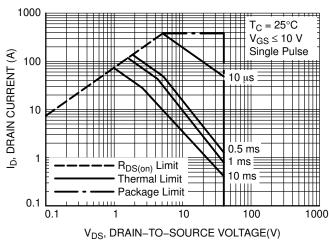


Figure 11. Maximum Rated Forward Biased Safe Operating Area

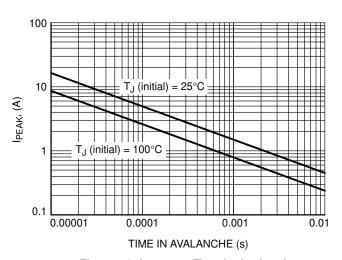


Figure 12. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS

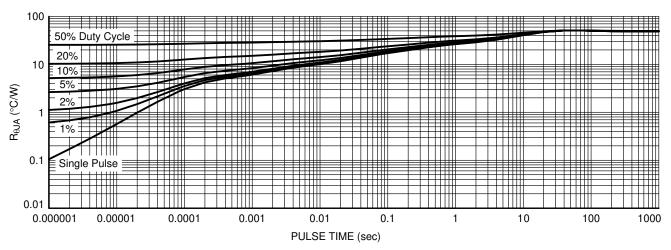
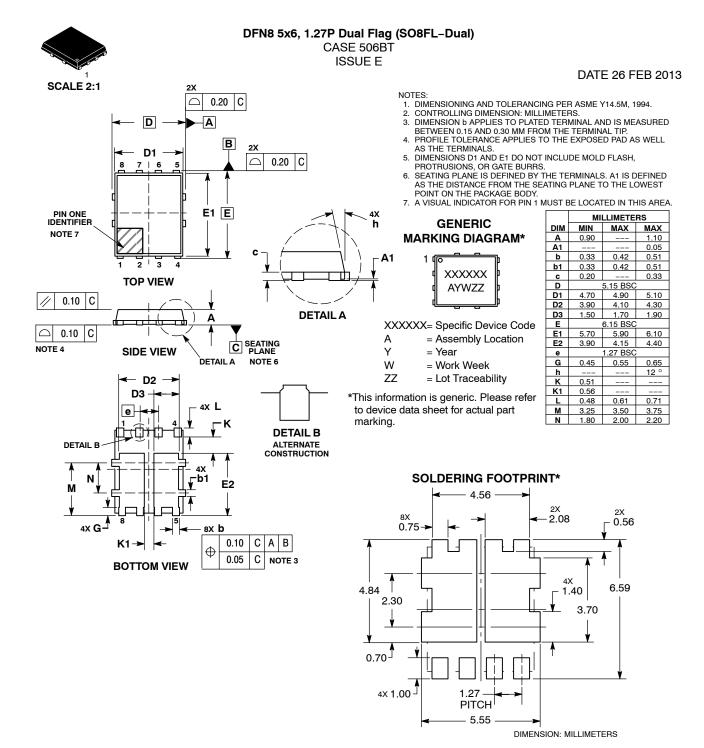


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVMFD5C478NLT1G	5C478L	DFN8 (Pb-Free)	1500 / Tape & Reel
NVMFD5C478NLWFT1G	478LWF	DFN8 (Pb-Free)	1500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DESCRIPTION:	DFN8 5X6, 1.27P DUAL FLAG (SO8FL-DUAL)		PAGE 1 OF 2	
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Α	CORRECTED SOLDER FOOTPRINT. REQ. BY I. CAMBALIZA.	16 FEB 2011
В	CORRECTED ERROR IN SOLDER FOOTPRINT SHAPE. REQ. BY I. CAMBALIZA.	29 JUN 2011
С	CORRECTED MARKING DIAGRAM TO ADD LOT TRACEABILITY. REQ. BY J. CARTER.	12 APR 2012
D	ADDED DIMENSION K1 TO BOTTOM VIEW AND TABLE. REQ. BY D. TRUHITTE.	11 JAN 2013
E	MODIFED DIMENSIONS D1 & E1 AND ADDED NOMINAL VALUES. REQ. BY I. MARIANO.	26 FEB 2013

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